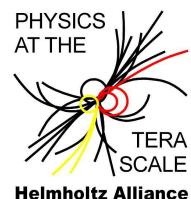


ATLAS Tau Identification: Electron Fake Rejection in Run II



Bundesministerium
für Bildung
und Forschung



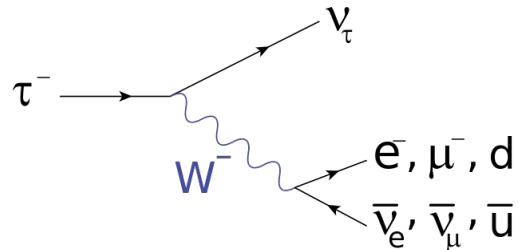
GEORG-AUGUST-UNIVERSITÄT
GÖTTINGEN

Eric Drechsler
16.11.2015, Mtautau Workshop
DESY, Hamburg



Overview

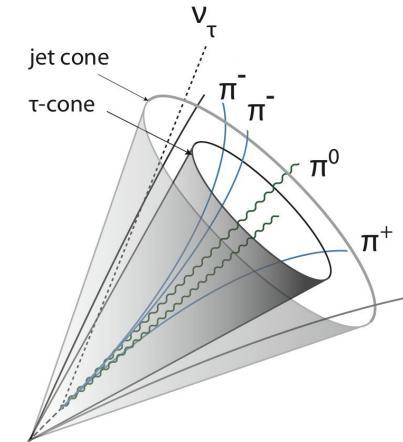
- I. Motivation
- II. Run II Electron Fake Rejection
- III. Efficiency Measurement
- IV. Summary



- ❖ heaviest lepton
 - mass: **1.777 GeV**
 - $\sim 87\mu\text{m}$ decay length
- ❖ hadronic decay channels (“ τ ”)
 - **50%** (15%) mit **1** (3) charged pions
 - main **backgrounds**: jets and **electrons**

Tau Leptons in ATLAS

1. Reconstruction
2. Identification - discrimination against:
 - a. Jets (multivariate BDT technique)
 - b. Electrons
3. Calibration
4. Scaling
 - a. scale factors from efficiency measurements



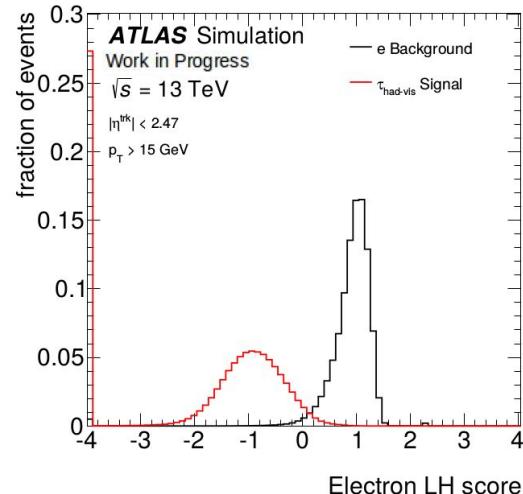
Changes in Run II:



- ❖ Performance changes:
 - IBL affecting tau-vertex resolution
 - calorimeter readout
- ❖ **new electron rejection method**
 - in harmony with electron identification
- ❖ reoptimised energy calibration, identification
- ❖ Substructure information

Electron Overlap Removal I - Method

- ❖ electrons e fake 1-track τ -candidates
- ❖ Run I: additional BDT for identification
- ❖ Run II: align with electron definition
 - discriminator for e: **likelihood score LH**
 - shower shape information from calorimeter
 - reconstructed hits in tracking detector
 - TRT information



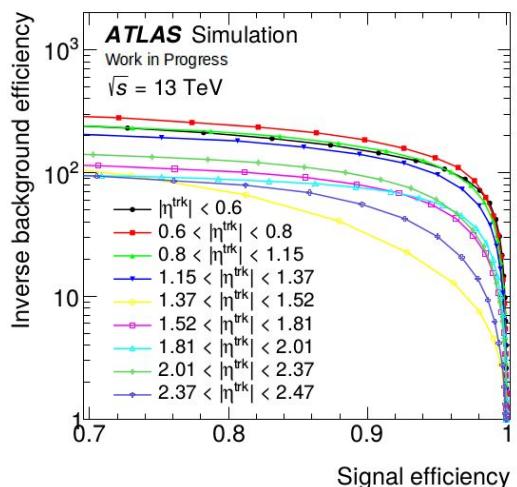
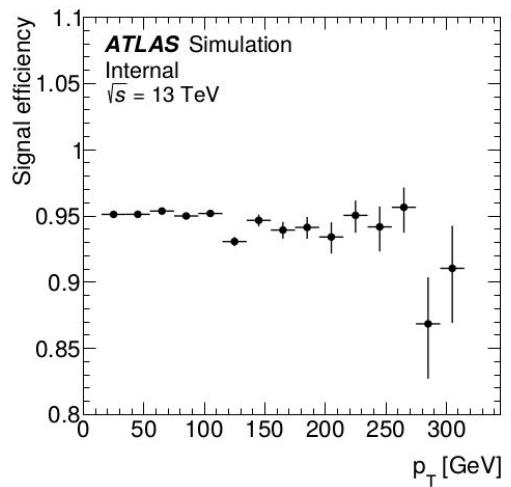
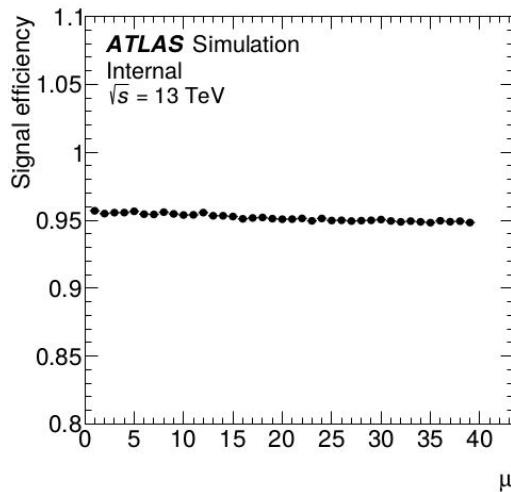
→ **overlap removal e > τ : EleOLR**

- dependent on electron **LH** and τ -candidate **kinematics**

Electron Overlap Removal II - Expected Results



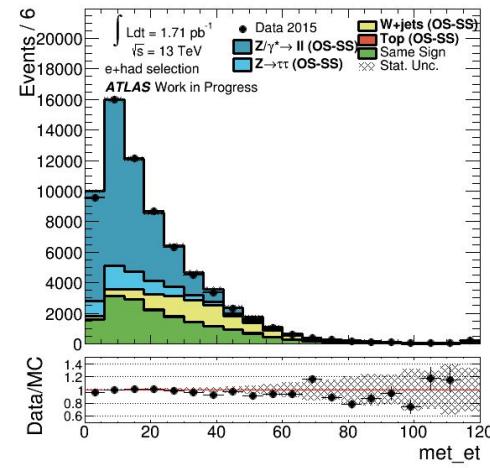
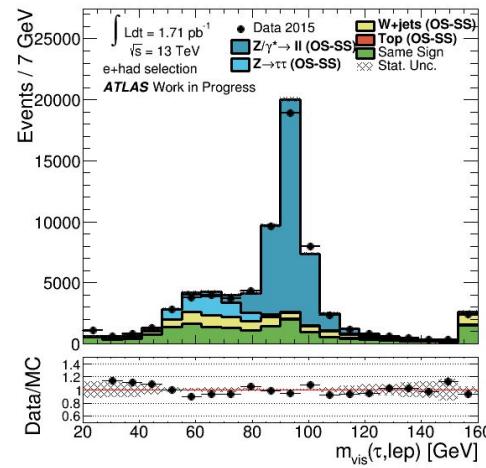
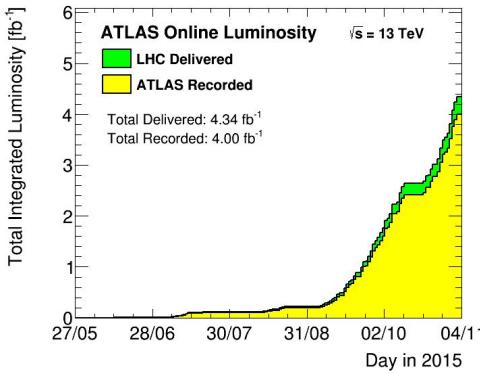
- ❖ cuts tuned
 - yield ~95% **signal efficiency** ($Z \rightarrow \tau\tau$)
- ❖ stable against $\langle \mu \rangle$
- ❖ flat in pseudorapidity and p_T



Efficiency measurement I - Tag & Probe



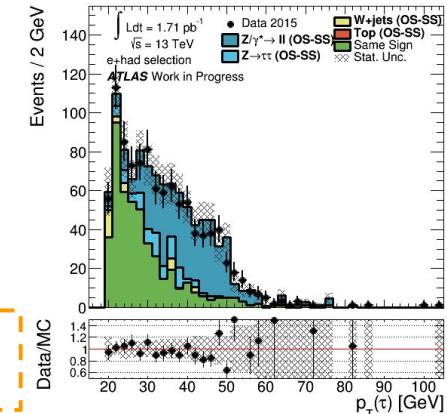
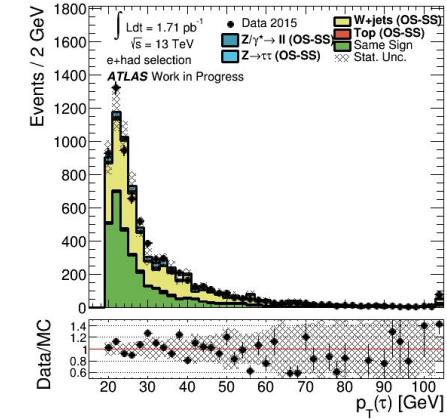
- ❖ aim: derive **scale factors** for EleOLR method
 - efficiency measurement in data and MC
- ❖ define tag- & probe-lepton pair
 - $e + \tau$ final states from Z-decay
 - measure efficiency on probe lepton



Efficiency measurement II - Bkgd Estimation

- ❖ Z \rightarrow ee from simulation
- ❖ background contributions:
 - Z \rightarrow $\tau\tau$, ttbar from simulation
 - W+Jets from simulation + scaling:
 - ★ define pure W region
 - ★ data/MC comparison - scalefactors
 - QCD multijets from data driven method “OS-SS”
 - ★ same charge for e and τ in data (SS)
 - ★ subtract SS simulated events from data
 - ★ extract shape of QCD background
 - ★ apply scale factor from QCD region R_{QCD}

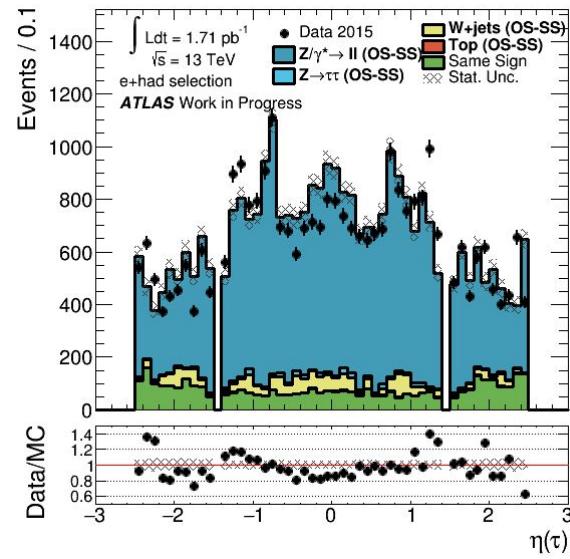
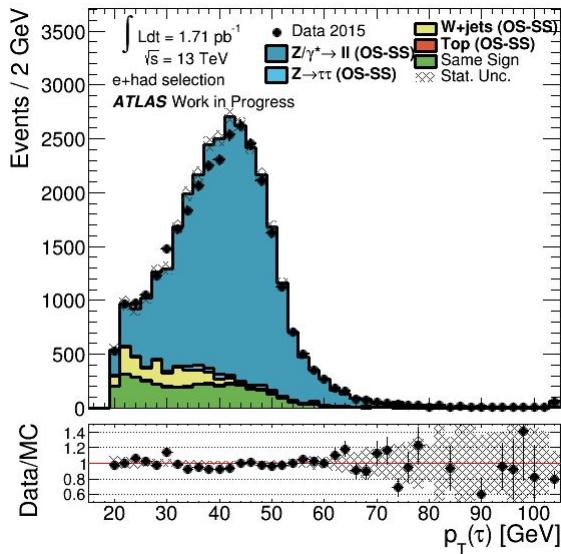
$$\text{bkgd}^{OS} = \frac{R_{QCD}}{(k_w^{SS} W^{SS} + Z\tau\tau^{SS} + \text{top}^{SS})} \text{Data}^{SS} + (k_w^{OS} W^{OS} Z\tau\tau^{OS} + \text{top}^{OS}) - R_{QCD}$$



Efficiency measurement IV - probe kinematics

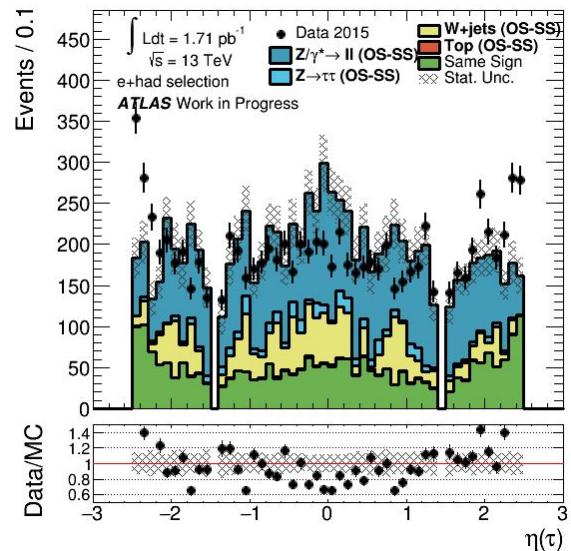
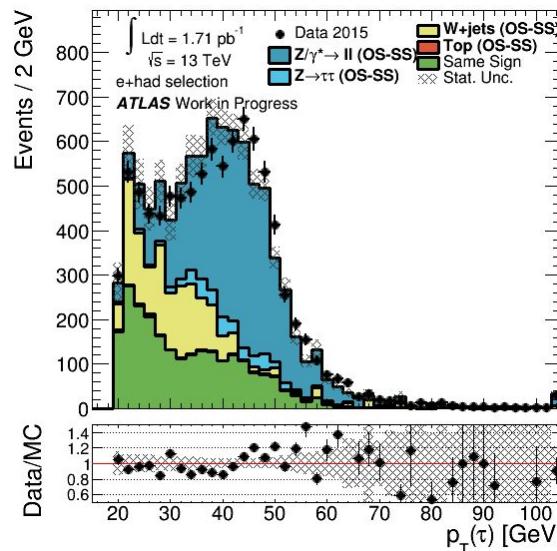
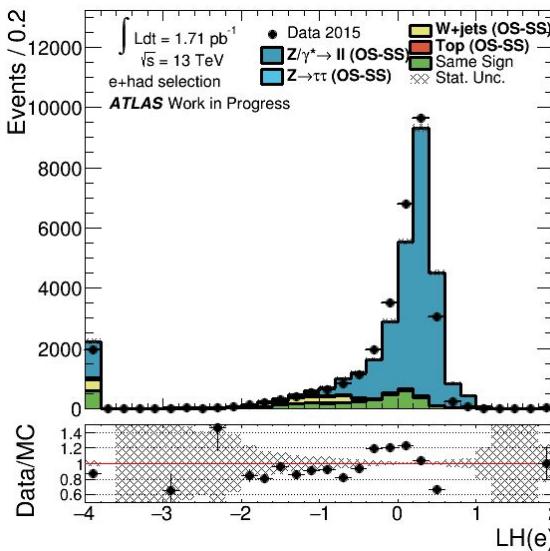


- ❖ inspection of probe lepton kinematics
 - properties of electrons faking taus
- ❖ good agreement, features under investigation



Efficiency measurement IV - Ele0lr application

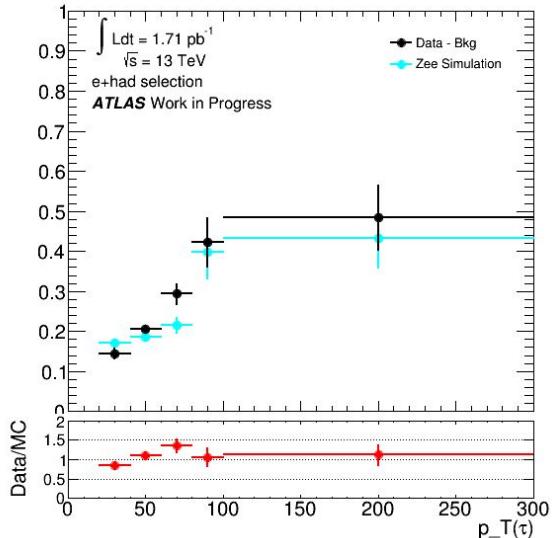
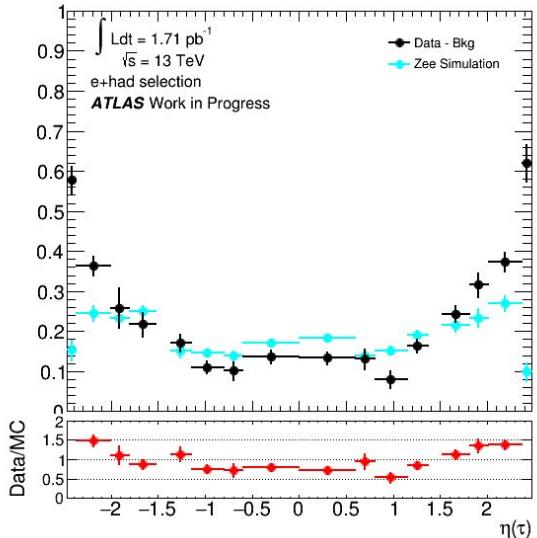
- ❖ application of Ele0LR on events
 - strongly dependent on electron LLH tune/configuration
 - discrepancy in high-eta from outdated LLH tune
 - sample purity not yet satisfactory



Efficiency Measurement V - Efficiency Calculation

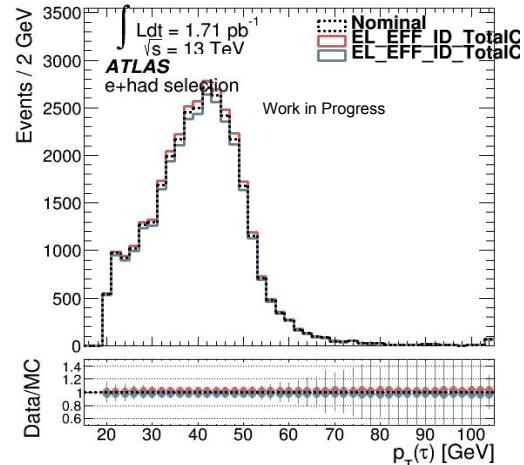
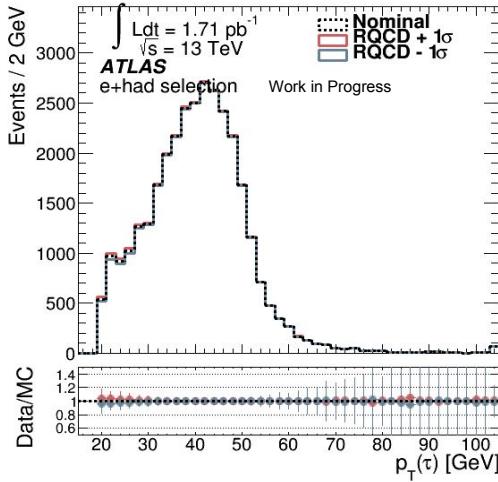


- ❖ calculate bin-by-bin efficiency in pT and eta
 - $\text{eff_bin} = \# \text{events after EleOLR} / \# \text{total events}$
- ❖ shown with binomial statistical errors
- ❖ calculate on data and MC
 - extract scalefactor bin by bin



Efficiency measurement V - Next Steps

- ❖ optimisation control & signal region definitions
- ❖ validation of background estimate
- ❖ inclusion of systematics
 - background estimation
 - efficiencies for electron
 - electron energy calibration/resolution
- ❖ retune cuts for EleOLR for new LH definition



Summary

- ❖ Run II: important changes for tau leptons in ATLAS
- ❖ new electron rejection
 - overlap removal EleOLR
 - based on electron likelihood
- ❖ efficiency measurement on data and MC
 - background estimation OS-SS
- ❖ extraction of scale factors
 - from data/MC comparison

